

In the Claims:

Claims 6, 11, 14, 17 and 20 have been amended as follows:

1 6. (Amended) A method according to claim 5 wherein the elements are
2 configured in an array of rows and columns, and including combining the resultant data for
3 at least a part of an individual one of the rows or columns, and comparing the combined data
4 with a threshold to provide an indication of a malfunction in the device.

11. (Amended) A method according to claim 1 wherein the display device is
2 mounted in an electronic apparatus with a back light operable to illuminate the display
3 device, including capturing the data corresponding to the first and second images with the
4 back light in use.

14. (Amended) Apparatus according to claim 13 wherein the test pattern generator
2 is configured to energise and de-energise the elements individually to produce the data
3 corresponding to the first and second images.

17. (Amended) Apparatus according to claim 12 wherein the processor is
2 configured to compare the image data for the first and second images to provide resultant
3 data corresponding to the functionality of the elements individually.